

<b>Notice of References Cited</b>	Application/Control No. 09/619,363	Applicant(s)/Patent Under Reexamination BLEILE ET AL.	
	Examiner T. Richard Lei	Art Unit 2684	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,466,799	10-2002	Torrey et al.	455/462
	B	US-5,555,258	09-1996	Snelling et al.	370/280
	C	US-6,366,784	04-2002	Hsueh, Chih-Yuan	455/462
	D	US-6,480,714	11-2002	DePani et al.	455/426
	E	US-5,526,403	06-1996	Tam, Ambrose W.C.	455/426
	F	US-6,487,403	11-2002	Carroll, Christopher Paul	455/419
	G	US-6,400,957	06-2002	Rodrigues et al.	455/462
	H	US-6,212,377	04-2001	Dufour et al.	455/426
	I	US-6,073,031	06-2000	Helstab et al.	455/557
	J	US-5,714,943	02-1998	Rasor, Gregg Edward	340/7.1
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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